



Institut luxembourgeois de la normalisation
de l'accréditation, de la sécurité et qualité
des produits et services

ILNAS-EN IEC 62836:2024

Measurement of internal electric field in insulating materials - Pressure wave propagation method

Mesurage du champ électrique interne
dans les matériaux isolants - Méthode de
l'onde de pression

Messung des inneren elektrischen Feldes
in Isoliermaterialien - Methode der
Druckwellenausbreitung

04/2024



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ILNAS-EN IEC 62836:2024

EUROPEAN STANDARD **EN IEC 62836**

NORME EUROPÉENNE

EUROPÄISCHE NORM

April 2024

ICS 17.220.99; 29.035.01

English Version

**Measurement of internal electric field in insulating materials -
Pressure wave propagation method
(IEC 62836:2024)**

Mesurage du champ électrique interne dans les matériaux
isolants - Méthode de l'onde de pression
(IEC 62836:2024)

Messung des inneren elektrischen Feldes in
Isoliermaterialien - Methode der Druckwellenausbreitung
(IEC 62836:2024)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

European foreword

The text of document 112/627/FDIS, future edition 1 of IEC 62836, prepared by IEC/TC 112 "Evaluation and qualification of electrical insulating materials and systems" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62836:2024.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2025-01-03
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2027-04-03

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INTERNATIONAL STANDARD

NORME INTERNATIONALE



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